

Sample &

Buy



bq27421-G1

SLUSB85C - MAY 2013 - REVISED DECEMBER 2014

# bq27421-G1 System-Side Impedance Track™ Fuel Gauge With Integrated Sense Resistor

Technical

Documents

# 1 Features

- Single Series Cell Li-Ion Battery Fuel Gauge
  - Resides on System Board
  - Supports Embedded or Removable Batteries
  - Powered Directly from Battery with Integrated LDO
  - Low-value Integrated Sense Resistor (7 mΩ, Typical)
- Easy-to-Configure Fuel Gauging Based on Patented Impedance Track<sup>™</sup> Technology
  - Reports Remaining Capacity and State-of-Charge (SOC) with Smoothing Filter
  - Automatically Adjusts for Battery Aging, Self-Discharge, Temperature, and Rate Changes
  - Battery State-of-Health (Aging) Estimation
- Microcontroller Peripheral Supports:
  - 400-kHz I<sup>2</sup>C Serial Interface
  - Configurable SOC Interrupt or Battery Low Digital Output Warning
  - Internal Temperature Sensor or Host-Reported Temperature

# 2 Applications

- Smartphones, Feature Phones, and Tablets
- Digital Still and Video Cameras
- Handheld Terminals
- MP3 or Multimedia Players

# **4** Simplified Schematic

# 3 Description

Tools &

Software

The Texas Instruments bq27421-G1 fuel gauge is an easy-to-configure microcontroller peripheral that provides system-side fuel gauging for single-cell Lilon batteries. The device requires minimal user configuration and system microcontroller firmware development.

Support &

Community

**.**...

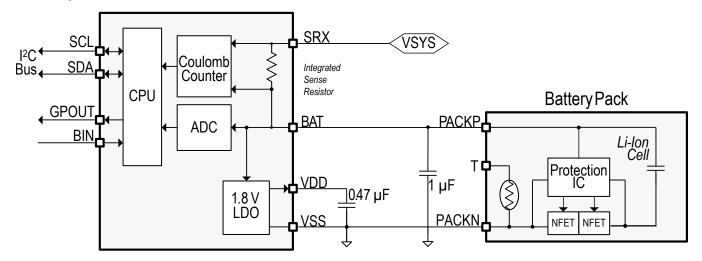
The bq27421-G1 fuel gauge uses the patented Impedance  $Track^{TM}$  algorithm for fuel gauging, and provides information such as remaining battery capacity (mAh), state-of-charge (%), and battery voltage (mV).

Battery fuel gauging with the bq27421-G1 fuel gauge requires connections only to PACK+ (P+) and PACK- (P-) for a removable battery pack or embedded battery circuit. The tiny 9-ball, 1.62 mm × 1.58 mm, 0.5-mm pitch NanoFree<sup>TM</sup> chip scale package (DSBGA) is ideal for space-constrained applications.

#### **Device Information**<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
bq27421-G1	DSBGA (9)	1.62 mm × 1.58 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



TEXAS INSTRUMENTS

www.ti.com

# **Table of Contents**

1	Feat	tures 1
2	Арр	lications 1
3	Des	cription 1
4	Sim	plified Schematic1
5	Rev	ision History 2
6	Dev	ice Comparison Table 3
7	Pin	Configuration and Functions 4
8	Spe	cifications5
	8.1	Absolute Maximum Ratings 5
	8.2	ESD Ratings 5
	8.3	Recommended Operating Conditions 5
	8.4	Thermal Information 5
	8.5	Supply Current 6
	8.6	Digital Input and Output DC Characteristics 6
	8.7	LDO Regulator, Wake-up, and Auto-shutdown DC Characteristics
	8.8	ADC (Temperature and Cell Measurement)
	0.0	Characteristics
	8.9	Integrating ADC (Coulomb Counter) Characteristics
	8.10	
	8.11	· · · · · · · · · · · · · · · · · · ·
		Characteristics

	8.12	Typical Characteristics	9
9	Deta	iled Description	10
	9.1	Overview	10
	9.2	Functional Block Diagram	10
	9.3	Feature Description	10
	9.4	Device Functional Modes	11
	9.5	Programming	11
10	Арр	lications and Implementation	15
	10.1	Application Information	15
	10.2	Typical Applications	16
11	Pow	er Supply Recommendation	
	11.1	Power Supply Decoupling	19
12	Lay	out	20
	12.1	Layout Guidelines	20
	12.2	Layout Example	20
13	Dev	ice and Documentation Support	21
	13.1	Documentation Support	21
	13.2	Trademarks	21
	13.3	Electrostatic Discharge Caution	21
	13.4	Glossary	21
14	Мес	hanical, Packaging, and Orderable	
		mation	21

# 5 Revision History

С	hanges from Revision B (November 2014) to Revision C	Page
•	Changed simplified schematic by adding 1-µF capacitor	
•	Added description for connecting a 1-µF capacitor	4
•	Added information for connecting GPOUT	4
•	Changed Handling Ratings to ESD Ratings	
	Changed connection description for BAT pin	
•	Changed recommend to required	

CI	hanges from Revision A (August 2014) to Revision B	Page
•	Added Typical Characteristics, Application Information, Design Requirements, and Application Curves	1
•	Changed the I <sub>lkg</sub> parameters	6
•	Deleted holding lines low enters low power sleep mode	13

Changes from Original (May 2013) to Revision A

		-
•	Added Device Information table	. 1
•	Changed LiMnO <sub>4</sub> to LiCoO <sub>2</sub>	. 3
•	Added bq27421-G1D device to data sheet	. 3
•	Updated BIN pin description	. 4
•	Updated GPOUT pin description	. 4
•	Added ESD Ratings	. 5
•	Added RemainingCapacityUnfiltered(), RemainingCapacityFiltered(), FullChargeCapacityUnfiltered(),	
	FullChargeCapacityFlitered(), and StateOfChargeUnfiltered() to Table 1	11
•	Added EXIT_CFGUPDATE and EXIT_RESIM subcommands to Table 2	12
•	Changed Chem_ID description	12

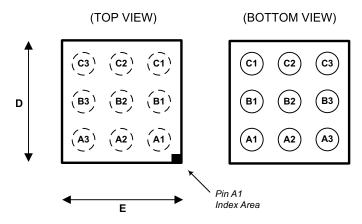
# 6 Device Comparison Table

PART NUMBER	BATTERY TYPE	CHEM_ID <sup>(1)</sup>	PACKAGE <sup>(2)</sup>	COMMUNICATION FORMAT		
bq27421YZFR-G1A	LiCoO <sub>2</sub>	0x128				
bq27421YZFT-G1A	(4.2 V maximum charge)	UX126				
bq27421YZFR-G1B	LiCoO <sub>2</sub>	0x312	CSP-9	l <sup>2</sup> C		
bq27421YZFT-G1B	(4.3 to 4.35 V maximum charge)	0x312	C3P-9	I-C		
bq27421YZFR-G1D	LiCoO <sub>2</sub>	0.2142				
bq27421YZFT-G1D	(4.3 to 4.4 V maximum charge)	0x3142				

(1) See the CHEM\_ID subcommand to confirm the battery chemistry type.

(2) For the most current package and ordering information see the Package Option Addendum at the end of this document; or, see the TI website at www.ti.com.

# 7 Pin Configuration and Functions



DIM	MIN	TYP	MAX	UNITS
D	1590	1620	1650	
E	1550	1580	1610	μm

#### **Pin Functions**

PIN		TYPE <sup>(1)</sup>	DESCRIPTION		
NAME	NUMBER	ITPE.	DESCRIPTION		
BAT	C3	PI, AI	LDO regulator input, battery voltage input, and coulomb counter input typically connected to the PACK+ terminal. Connect a capacitor (1 $\mu$ F) between BAT and V <sub>SS</sub> . Place the capacitor close to the gauge.		
BIN	B1	DI	Battery insertion detection input. If <b>Operation Configuration</b> bit <b>[BIE]</b> = 1 (default), a logic low on the pin is detected as battery insertion. For a removable pack, the BIN pin can be connected to $V_{SS}$ through a pulldown resistor on the pack, typically the 10-k $\Omega$ thermistor; the system board should use a 1.8-M $\Omega$ pullup resistor to $V_{DD}$ to ensure the BIN pin is high when a battery is removed. If the battery is embedded in the system, it is recommended to leave <b>[BIE]</b> = 1 and use a 10-k $\Omega$ pulldown resistor from BIN to $V_{SS}$ . If <b>[BIE]</b> = 0, then the host must inform the gauge of battery insertion and removal with the BAT_INSERT and BAT_REMOVE subcommands. A 10-k $\Omega$ pulldown resistor should be placed between BIN and $V_{SS}$ , even if this pin is unused. <b>NOTE:</b> The BIN pin must not be shorted directly to $V_{CC}$ or $V_{SS}$ and any pullup resistor on the BIN pin must be connected only to $V_{DD}$ and not an external voltage rail.		
GPOUT	A1	DO	This open-drain output can be configured to indicate BAT_LOW when the <b>Operation Configurati [BATLOWEN]</b> bit is set. By default <b>[BATLOWEN]</b> is cleared and this pin performs an interrupt function (SOC_INT) by pulsing for specific events, such as a change in State of Charge. Signal polarity for these functions is controlled by the <b>[GPIOPOL]</b> configuration bit. This pin should not be left floating, even if unused, so a 10-k $\Omega$ pullup resistor is recommended. If the device is in shutdow mode, then toggling GPOUT will make the gauge exit shutdown. Therefore, it is recommended to connect GPOUT to a GPIO of the host MCU.		
SCL	A3	DIO	Slave I <sup>2</sup> C serial bus for communication with system (Master). Open-drain pins. Use with external		
SDA	A2	DIO	10-k $\Omega$ pullup resistors (typical) for each pin. If the external pullup resistors will be disconnected from these pins during normal operation, recommend using external 1-M $\Omega$ pulldown resistors to V <sub>SS</sub> at each pin to avoid floating inputs.		
SRX	C2	AI	Integrated high-side sense resistor and coulomb counter input typically connected to system power rail VSYS.		
V <sub>DD</sub>	B3	PO	1.8-V Regulator Output. Decouple with 0.47- $\mu$ F ceramic capacitor to V <sub>SS</sub> . This pin is not intended to provide power for other devices in the system.		
V <sub>SS</sub>	B2, C1	PI	Ground pins. The center pin B2 is the actual device ground pin while pin C1 is floating internally therefore C1 may be used as a bridge to connect to the board ground plane without requiring a vunder the device package. Recommend routing the center pin B2 to the corner pin C1 using a to layer metal trace on the board. Then route the corner pin C1 to the board ground plane.		

(1) IO = Digital input-output, AI = Analog input, P = Power connection



# 8 Specifications

# 8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>BAT</sub>	BAT pin input voltage range	-0.3	6	V
V <sub>SRX</sub>	SRX pin input voltage range	$V_{BAT} - 0.3$	V <sub>BAT</sub> + 0.3	V
V <sub>DD</sub>	V <sub>DD</sub> pin supply voltage range (LDO output)	-0.3	2	V
V <sub>IOD</sub>	Open-drain IO pins (SDA, SCL, GPOUT)	-0.3	6	V
VIOPP	Push-pull IO pins (BIN)	-0.3	V <sub>DD</sub> + 0.3	V
T <sub>A</sub>	Operating free-air temperature range	-40	85	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 8.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1500	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 $^{\left( 2\right) }$	±250	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# 8.3 Recommended Operating Conditions

 $T_A = 30^{\circ}C$  and  $V_{REGIN} = V_{BAT} = 3.6V$  (unless otherwise noted)

			MIN	TYP	MAX	UNIT
$C_{BAT}^{(1)}$	External input capacitor for internal LDO between BAT and $V_{SS}$	Nominal capacitor values specified.		0.1		μF
C <sub>LDO18</sub> <sup>(1)</sup>	External output capacitor for internal LDO between $\rm V_{DD}$ and $\rm V_{SS}$	Recommend a 5% ceramic X5R-type capacitor located close to the device.		0.47		μF
$V_{PU}^{(1)}$	External pull-up voltage for open- drain pins (SDA, SCL, GPOUT)		1.62		3.6	V

(1) Specified by design. Not production tested.

## 8.4 Thermal Information

over operating free-air temperature range (unless otherwise noted)

	THERMAL METRIC <sup>(1)</sup>	bq27421-G1	
		YZF (9 PINS)	UNIT
$R_{\thetaJA}$	Junction-to-ambient thermal resistance	107.8	
R <sub>0JCtop</sub>	Junction-to-case (top) thermal resistance	0.7	
$R_{\theta JB}$	Junction-to-board thermal resistance	60.4	°C/₩
ΨJT	Junction-to-top characterization parameter	3.5	C/VV
$\Psi_{JB}$	Junction-to-board characterization parameter	60.4	
$R_{\theta JCbot}$	Junction-to-case (bottom) thermal resistance	NA	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

bq27421-G1

SLUSB85C - MAY 2013 - REVISED DECEMBER 2014

# 8.5 Supply Current

 $T_A = 30^{\circ}C$  and  $V_{REGIN} = V_{BAT} = 3.6$  V (unless otherwise noted)

11						
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{CC}^{(1)}$	NORMAL mode current	I <sub>LOAD</sub> > Sleep Current <sup>(2)</sup>		93		μA
I <sub>SLP</sub> <sup>(1)</sup>	SLEEP mode current	I <sub>LOAD</sub> < Sleep Current <sup>(2)</sup>		21		μA
I <sub>HIB</sub> <sup>(1)</sup>	HIBERNATE mode current	I <sub>LOAD</sub> < Hibernate Current <sup>(2)</sup>		9		μA
$I_{SD}^{(1)}$	SHUTDOWN mode current	Fuel gauge in host commanded SHUTDOWN mode (LDO regulator output disabled)		0.6		μΑ

(1) Specified by design. Not production tested.

(2) Wake Comparator Disabled.

# 8.6 Digital Input and Output DC Characteristics

 $T_{A}$  = –40°C to 85°C, typical values at  $T_{A}$  = 30°C and  $V_{REGIN}$  = 3.6 V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IH(OD)</sub>	Input voltage, high <sup>(2)</sup>	External pullup resistor to $V_{\text{PU}}$	V <sub>PU</sub> × 0.7			V
VIL	Input voltage, low <sup>(2)</sup> (3)				0.6	V
V <sub>OL</sub>	Output voltage, low <sup>(2)</sup>				0.6	V
I <sub>OH</sub>	Output source current, high <sup>(2)</sup> <sup>(3)</sup>				0.5	mA
I <sub>OL(OD)</sub>	Output sink current, low <sup>(2)</sup>				-3	mA
$C_{IN}^{(1)}$	Input capacitance <sup>(2) (3)</sup>				5	pF
l <sub>ikg</sub>	Input leakage current (SCL, SDA, BIN)				0.1	μA
ing	Input leakage current (GPOUT)				1	-

(1) Specified by design. Not production tested.

(2) Open Drain pins: (SCL, SDA, GPOUT)

(3) Push-pull pin: (BIN)

## 8.7 LDO Regulator, Wake-up, and Auto-shutdown DC Characteristics

 $T_{A}$  = –40°C to 85°C, typical values at  $T_{A}$  = 30°C and  $V_{REGIN}$  = 3.6 V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>BAT</sub>	BAT pin regulator input		2.45		4.5	V
V <sub>DD</sub>	Regulator output voltage			1.8		V
UVLO <sub>IT+</sub>	V <sub>BAT</sub> undervoltage lockout LDO wake-up rising threshold			2		V
UVLO <sub>IT-</sub>	V <sub>BAT</sub> undervoltage lockout LDO auto-shutdown falling threshold			1.95		V

(1) Specified by design. Not production tested.

## 8.8 ADC (Temperature and Cell Measurement) Characteristics

 $T_A = -40^{\circ}$ C to 85°C; typical values at  $T_A = 30^{\circ}$ C and  $V_{REGIN} = 3.6$  V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IN(BAT)</sub>	BAT pin voltage measurement range.	Voltage divider enabled.	2.45		4.5	V
	Conversion time			125		ms
tADC_CONV	Effective resolution			15		bits

(1) Specified by design. Not tested in production.

# 8.9 Integrating ADC (Coulomb Counter) Characteristics

 $T_A = -40^{\circ}$ C to 85°C; typical values at  $T_A = 30^{\circ}$ C and  $V_{REGIN} = 3.6$  V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>SR</sub>	Input voltage range from BAT to SRX pins		E	3AT ± 25		mV
t <sub>SR_CONV</sub>	Conversion time	Single conversion		1		S
	Effective Resolution	Single conversion		16		bits

(1) Assured by design. Not tested in production.

# 8.10 Integrated Sense Resistor Characteristics

 $T_A = -40^{\circ}$ C to 85°C; typical values at  $T_A = 30^{\circ}$ C and  $V_{REGIN} = 3.6$  V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SRX <sub>RES</sub> <sup>(2)</sup>	Resistance of Integrated Sense Resistor from SRX to BAT.	$T_A = 30^{\circ}C$		7		mΩ
		Long term RMS, average device utilization			2000	mA
I <sub>SRX</sub> <sup>(1)</sup>	Recommended Sense Resistor input current.	Peak RMS current, 10% device utilization <sup>(3)</sup>			2500	mA
		Peak pulsed current, 250 ms maximum, 1% device utilization <sup>(3)</sup>			3500	mA

Specified by design. Not tested in production.
 Firmware compensation applied for temperature coefficient of resistor.

(3) Device utilization is the long term usage profile at a specific condition compared to the average condition.

NSTRUMENTS

EXAS

# 8.11 I<sup>2</sup>C-Compatible Interface Communication Timing Characteristics

 $T_A = -40^{\circ}C$  to 85°C; typical values at  $T_A = 30^{\circ}C$  and  $V_{REGIN} = 3.6$  V (unless otherwise noted)

			MIN	TYP	MAX	UNIT
Standard	Mode (100 kHz)					
t <sub>d(STA)</sub>	Start to first falling edge of SCL		4			μs
t <sub>w(L)</sub>	SCL pulse duration (low)		4.7			μs
t <sub>w(H)</sub>	SCL pulse duration (high)		4			μs
t <sub>su(STA)</sub>	Setup for repeated start		4.7			μs
t <sub>su(DAT)</sub>	Data setup time	Host drives SDA	250			ns
t <sub>h(DAT)</sub>	Data hold time	Host drives SDA	0			ns
t <sub>su(STOP)</sub>	Setup time for stop		4			μs
t <sub>(BUF)</sub>	Bus free time between stop and start	Includes Command Waiting Time	66			μs
t <sub>f</sub>	SCL or SDA fall time <sup>(1)</sup>				300	ns
t <sub>r</sub>	SCL or SDA rise time <sup>(1)</sup>				300	ns
f <sub>SCL</sub>	Clock frequency <sup>(2)</sup>				100	kHz
Fast Mode	e (400 kHz)		-			
t <sub>d(STA)</sub>	Start to first falling edge of SCL		600			ns
t <sub>w(L)</sub>	SCL pulse duration (low)		1300			ns
t <sub>w(H)</sub>	SCL pulse duration (high)		600			ns
t <sub>su(STA)</sub>	Setup for repeated start		600			ns
t <sub>su(DAT)</sub>	Data setup time	Host drives SDA	100			ns
t <sub>h(DAT)</sub>	Data hold time	Host drives SDA	0			ns
t <sub>su(STOP)</sub>	Setup time for stop		600			ns
t <sub>(BUF)</sub>	Bus free time between stop and start	Includes Command Waiting Time	66			μs
t <sub>f</sub>	SCL or SDA fall time <sup>(1)</sup>				300	ns
t <sub>r</sub>	SCL or SDA rise time <sup>(1)</sup>				300	ns
f <sub>SCL</sub>	Clock frequency <sup>(2)</sup>				400	kHz

(1)

Specified by design. Not production tested. If the clock frequency ( $f_{SCL}$ ) is > 100 kHz, use 1-byte write commands for proper operation. All other transactions types are supported at (2) 400 kHz. (See and )

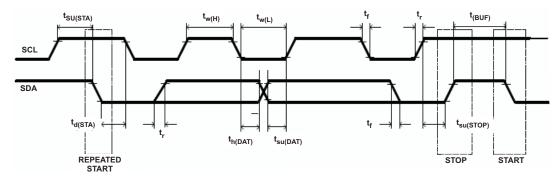
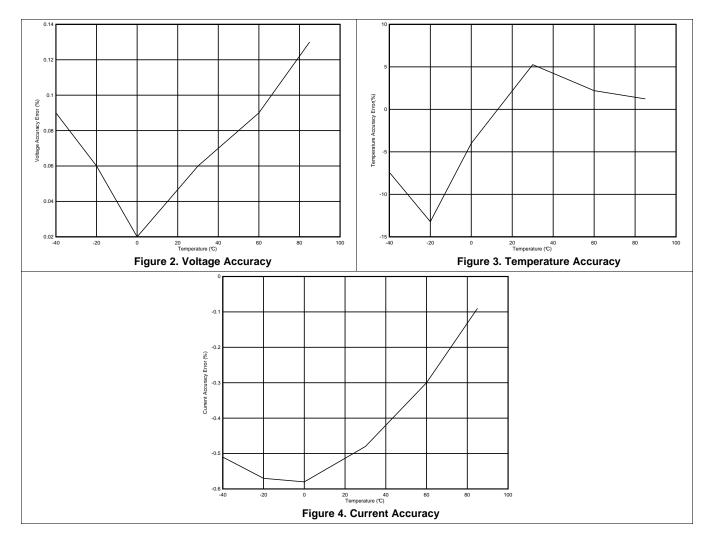


Figure 1. I<sup>2</sup>C-Compatible Interface Timing Diagrams



# 8.12 Typical Characteristics





# 9 Detailed Description

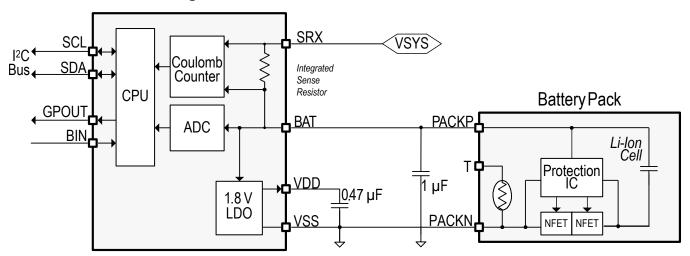
## 9.1 Overview

The fuel gauge accurately predicts the battery capacity and other operational characteristics of a single Li-based rechargeable cell. It can be interrogated by a system processor to provide cell information, such as state-of-charge (SOC).

#### NOTE

The following formatting conventions are used in this document: Commands: *italics* with parentheses() and no breaking spaces, for example, *Control()* Data Flash: *italics*, bold, and breaking spaces, for example, *Design Capacity* Register bits and flags: *italics* with brackets [], for example, *[TDA]* Data Flash bits: *italics*, bold, and brackets [], for example, *[LED1]* Modes and states: ALL CAPITALS, for example, UNSEALED mode

## 9.2 Functional Block Diagram



## 9.3 Feature Description

Information is accessed through a series of commands, called *Standard Commands*. Further capabilities are provided by the additional *Extended Commands* set. Both sets of commands, indicated by the general format *Command()*, are used to read and write information contained within the control and status registers, as well as its data locations. Commands are sent from system to gauge using the I<sup>2</sup>C serial communications engine, and can be executed during application development, system manufacture, or end-equipment operation.

The key to the high-accuracy gas gauging prediction is Texas Instruments proprietary Impedance Track<sup>™</sup> algorithm. This algorithm uses cell measurements, characteristics, and properties to create state-of-charge predictions that can achieve high-accuracy across a wide variety of operating conditions and over the lifetime of the battery.

The fuel gauge measures the charging and discharging of the battery by monitoring the voltage across a smallvalue sense resistor. When a cell is attached to the fuel gauge, cell impedance is computed, based on cell current, cell open-circuit voltage (OCV), and cell voltage under loading conditions.

The fuel gauge uses an integrated temperature sensor for estimating cell temperature. Alternatively, the host processor can provide temperature data for the fuel gauge.



#### Feature Description (continued)

More details are found in the bq27421-G1 Technical Reference Manual (SLUUAC5).

## 9.4 Device Functional Modes

To minimize power consumption, the fuel gauge has several power modes: INITIALIZATION, NORMAL, SLEEP, HIBERNATE, and SHUTDOWN. The fuel gauge passes automatically between these modes, depending upon the occurrence of specific events, though a system processor can initiate some of these modes directly. More details are found in the *bq27421-G1 Technical Reference Manual* (SLUUAC5).

## 9.5 Programming

### 9.5.1 Standard Data Commands

The fuel gauge uses a series of 2-byte standard commands to enable system reading and writing of battery information. Each standard command has an associated command-code pair, as indicated in Table 1. Because each command consists of two bytes of data, two consecutive I<sup>2</sup>C transmissions must be executed both to initiate the command function, and to read or write the corresponding two bytes of data. Additional details are found in the *bq27421-G1 Technical Reference Manual* (SLUUAC5).

NAME		COMMAND CODE	UNIT	SEALED ACCESS				
Control()	CNTL	0x00 and 0x01	NA	RW				
Temperature()	TEMP	0x02 and 0x03	0.1°K	RW				
Voltage()	VOLT	0x04 and 0x05	mV	R				
Flags()	FLAGS	0x06 and 0x07	NA	R				
NominalAvailableCapacity()		0x08 and 0x09	mAh	R				
FullAvailableCapacity()		0x0A and 0x0B	mAh	R				
RemainingCapacity()	RM	0x0C and 0x0D	mAh	R				
FullChargeCapacity()	FCC	0x0E and 0x0F	mAh	R				
AverageCurrent()		0x10 and 0x11	mA	R				
StandbyCurrent()		0x12 and 0x13	mA	R				
MaxLoadCurrent()		0x14 and 0x15	mA	R				
AveragePower()		0x18 and 0x19	mW	R				
StateOfCharge()	SOC	0x1C and 0x1D	%	R				
InternalTemperature()		0x1E and 0x1F	0.1°K	R				
StateOfHealth()	SOH	0x20 and 0x21	num / %	R				
RemainingCapacityUnfiltered()		0x28 and 0x29	mAh	R				
RemainingCapacityFiltered()		0x2A and 0x2B	mAh	R				
FullChargeCapacityUnfiltered()		0x2C and 0x2D	mAh	R				
FullChargeCapacityFlitered()		0x2E and 0x2F	mAh	R				
StateOfChargeUnfiltered()		0x30 and 0x31	%	R				

#### **Table 1. Standard Commands**



#### 9.5.2 *Control()*: 0x00 and 0x01

Issuing a *Control()* command requires a subsequent 2-byte subcommand. These additional bytes specify the particular control function desired. The *Control()* command allows the system to control specific features of the fuel gauge during normal operation and additional features when the device is in different access modes, as described in Table 2. Additional details are found in the *bq27421-G1 Technical Reference Manual* (SLUUAC5).

CNTL FUNCTION	CNTL DATA	SEALED ACCESS	DESCRIPTION
CONTROL_STATUS	0x0000	Yes	Reports the status of device
DEVICE_TYPE	0x0001	Yes	Reports the device type (0x0421)
FW_VERSION	0x0002	Yes	Reports the firmware version of the device
DM_CODE	0x0004	Yes	Reports the Data Memory Code number stored in NVM
PREV_MACWRITE	0x0007	Yes	Returns previous MAC command code
CHEM_ID	0x0008	Yes	Reports the chemical identifier of the battery profile used by the fuel gauge
BAT_INSERT	0x000C	Yes	Forces the Flags() [BAT_DET] bit set when the OpConfig [BIE] bit is 0
BAT_REMOVE	0x000D	Yes	Forces the Flags() [BAT_DET] bit clear when the <b>OpConfig [BIE]</b> bit is 0
SET_HIBERNATE	0x0011	Yes	Forces CONTROL_STATUS [HIBERNATE] to 1
CLEAR_HIBERNATE	0x0012	Yes	Forces CONTROL_STATUS [HIBERNATE] to 0
SET_CFGUPDATE	0x0013	No	Force CONTROL_STATUS [CFGUPMODE] to 1 and gauge enters CONFIG UPDATE mode
SHUTDOWN_ENABLE	0x001B	No	Enables device SHUTDOWN mode
SHUTDOWN	0x001C	No	Commands the device to enter SHUTDOWN mode
SEALED	0x0020	No	Places the device in SEALED access mode
TOGGLE_GPOUT	0x0023	Yes	Commands the device to toggle the GPOUT pin for 1 ms
RESET	0x0041	No	Performs a full device reset
SOFT_RESET	0x0042	No	Gauge exits CONFIG UPDATE mode
EXIT_CFGUPDATE	0x0043	No	Exits CONFIG UPDATE mode without an OCV measurement and without resimulating to update <i>StateOfCharge()</i>
EXIT_RESIM	0x0044	No	Exits CONFIG UPDATE mode without an OCV measurement and resimulates with the updated configuration data to update <i>StateOfCharge()</i>

#### Table 2. Control() Subcommands

#### 9.5.3 Extended Data Commands

Extended data commands offer additional functionality beyond the standard set of commands. They are used in the same manner; however, unlike standard commands, extended commands are not limited to 2-byte words. The number of command bytes for a given extended command ranges in size from single to multiple bytes, as specified in Table 3.

Table 3. Extended Commands							
	Command Code	Unit	SEAL				

Name	Command Code	Unit	SEALED Access <sup>(1)</sup> <sup>(2)</sup>	UNSEALED Access <sup>(1)</sup> <sup>(2)</sup>
OpConfig()	0x3A and 0x3B	NA	R	R
DesignCapacity()	0x3C and 0x3D	mAh	R	R
DataClass() <sup>(2)</sup>	0x3E	NA	NA	RW
DataBlock() <sup>(2)</sup>	0x3F	NA	RW	RW
BlockData()	0x40 through 0x5F	NA	R	RW
BlockDataCheckSum()	0x60	NA	RW	RW
BlockDataControl()	0x61	NA	NA	RW
Reserved	0x62 through 0x7F	NA	R	R

(1) SEALED and UNSEALED states are entered via commands to Control() 0x00 and 0x01

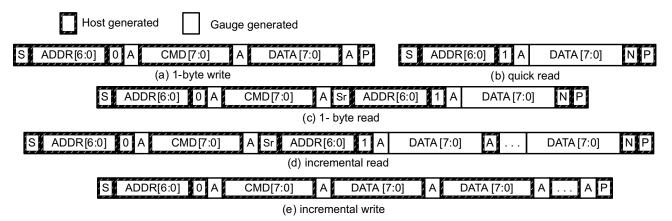
(2) In SEALED mode, data cannot be accessed through commands 0x3E and 0x3F.



#### 9.5.4 Communications

## 9.5.4.1 PC Interface

The fuel gauge supports the standard I<sup>2</sup>C read, incremental read, quick read, one-byte write, and incremental write functions. The 7-bit device address (ADDR) is the most significant 7 bits of the hex address and is fixed as 1010101. The first 8 bits of the I<sup>2</sup>C protocol are, therefore, 0xAA or 0xAB for write or read, respectively.



(S = Start, Sr = Repeated Start, A = Acknowledge, N = No Acknowledge, and P = Stop).

The quick read returns data at the address indicated by the address pointer. The address pointer, a register internal to the  $I^2C$  communication engine, increments whenever data is acknowledged by the fuel gauge or the  $I^2C$  master. "Quick writes" function in the same manner and are a convenient means of sending multiple bytes to consecutive command locations (such as two-byte commands that require two bytes of data).

The following command sequences are not supported:

Attempt to write a read-only address (NACK after data sent by master):

	S ADDR[6:0] 0 A		A DATA[7:0] N P
--	-----------------	--	-----------------

Attempt to read an address above 0x6B (NACK command):

s	ADDR[6:0]	CMD[7:0]	NP
			·

### 9.5.4.2 **PC** Time Out

The  $I^2C$  engine releases both SDA and SCL if the  $I^2C$  bus is held low for 2 seconds. If the fuel gauge is holding the lines, releasing them frees them for the master to drive the lines.

#### TEXAS INSTRUMENTS

#### bq27421-G1

SLUSB85C - MAY 2013 - REVISED DECEMBER 2014

www.ti.com

#### 9.5.4.3 PC Command Waiting Time

To ensure proper operation at 400 kHz, a  $t_{(BUF)} \ge 66 \ \mu s$  bus-free waiting time must be inserted between all packets addressed to the fuel gauge. In addition, if the SCL clock frequency ( $f_{SCL}$ ) is > 100 kHz, use individual 1-byte write commands for proper data flow control. The following diagram shows the standard waiting time required between issuing the control subcommand the reading the status result. For read-write standard command, a minimum of 2 seconds is required to get the result updated. For read-only standard commands, there is no waiting time required, but the host must not issue any standard command more than two times per second. Otherwise, the gauge could result in a reset issue due to the expiration of the watchdog timer.

S ADDR [6:0] 0 A	CMD [7:0]	A DATA [7:0]	AP	66µs				
S ADDR [6:0] 0 A	CMD [7:0]	A DATA [7:0]	AP	66µs				
S ADDR [6:0] 0 A	CMD [7:0]	A Sr ADDR [6:	0] 1 A	DATA [7:0]	A	DATA [7:0]	N P	66µs

Waiting time inserted between two 1-byte write packets for a subcommand and reading results (required for 100 kHz <  $f_{scl} \le 400$  kHz)

S ADDR [6:0] 0 A	CMD [7:0] A	DATA [7:0]	DATA [7:0]	ΑP	<mark>66μs</mark>		
S ADDR [6:0] 0 A	CMD [7:0] A	Sr ADDR [6:0]	1 A DATA [7:0]	A	DATA [7:0]	N P	66µs

Waiting time inserted between incremental 2-byte write packet for a subcommand and reading results (acceptable for  $f_{scL} \le 100$  kHz)

S ADDR [6:0] 0	A CMD [7:0]	A	Sr ADDR	[6:0] 1 A	DATA [7:0]	A	DATA [7:0]	A
DATA [7:0] A	DATA [7:0]	N P	66µs					

Waiting time inserted after incremental read

### 9.5.4.4 PC Clock Stretching

A clock stretch can occur during all modes of fuel gauge operation. In SLEEP and HIBERNATE modes, a short  $\leq$  100-µs clock stretch occurs on all I<sup>2</sup>C traffic as the device must wake-up to process the packet. In the other modes (INITIALIZATION, NORMAL) a  $\leq$  4-ms clock stretching period may occur within packets addressed for the fuel gauge as the I<sup>2</sup>C interface performs normal data flow control.



# 10 Applications and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### **10.1** Application Information

The Texas Instruments bq27421-G1 fuel gauge is a microcontroller peripheral that provides system-side fuel gauging for single-cell Li-Ion batteries. The device requires minimal user configuration and system microcontroller firmware. Battery fuel gauging with the bq27421-G1 fuel gauge requires connections only to PACK+ (P+) and PACK– for a removable battery pack or embedded battery circuit.

#### NOTE

To allow for optimal performance in the end application, special considerations must be taken to ensure minimization of measurement error through proper printed circuit board (PCB) board layout. Such requirements are detailed in *Design Requirements*.

TEXAS INSTRUMENTS

**bq27421-G1** SLUSB85C-MAY 2013-REVISED DECEMBER 2014

www.ti.com

# **10.2 Typical Applications**

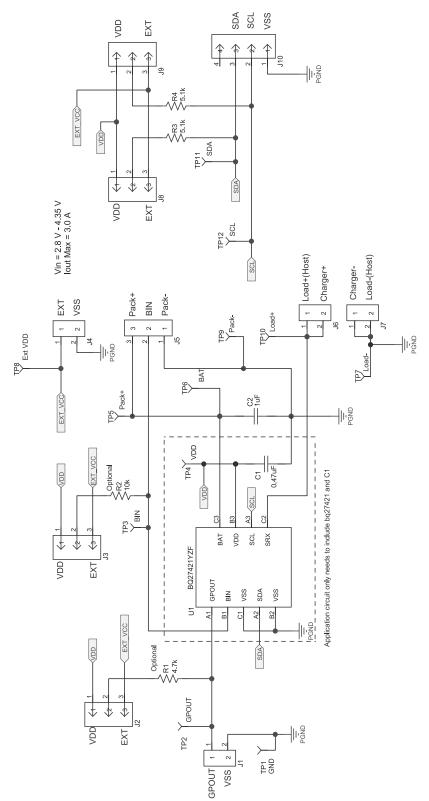


Figure 5. Application Schematic



## **Typical Applications (continued)**

#### 10.2.1 Design Requirements

As shipped from the Texas Instruments factory, many bq27421-G1 parameters in OTP NVM are left in the unprogrammed state (zero) while some parameters directly associated with the CHEMID are preprogrammed. This partially programmed configuration facilitates customization for each end application. Upon device reset, the contents of OTP are copied to associated volatile RAM-based Data Memory blocks. For proper operation, all parameters in RAM-based Data Memory require initialization — either by updating Data Memory parameters in a lab/evaluation situation or by programming the OTP for customer production. Chapter 6 in the *bq27421-G1 Technical Reference Manual* (SLUUAC5) shows the default value that is present.

#### 10.2.2 Detailed Design Procedure

### 10.2.2.1 BAT Voltage Sense Input

A ceramic capacitor at the input to the BAT pin is used to bypass AC voltage ripple to ground, greatly reducing its influence on battery voltage measurements. It proves most effective in applications with load profiles that exhibit high-frequency current pulses (that is, cell phones) but is recommended for use in all applications to reduce noise on this sensitive high-impedance measurement node.

### 10.2.2.2 Integrated LDO Capacitor

The fuel gauge has an integrated LDO with an output on the VDD pin of approximately 1.8 V. A capacitor of value at least 0.47  $\mu$ F should be connected between the VDD pin and VSS. The capacitor should be placed close to the gauge IC and have short traces to both the VDD pin and VSS.

### 10.2.2.3 Sense Resistor Selection

Any variation encountered in the resistance present between the SRP and SRN pins of the fuel gauge will affect the resulting differential voltage, and derived current, it senses. As such, it is recommended to select a sense resistor with minimal tolerance and temperature coefficient of resistance (TCR) characteristics. The standard recommendation based on best compromise between performance and price is a 1% tolerance, 50 ppm drift sense resistor with a 1-W power rating.

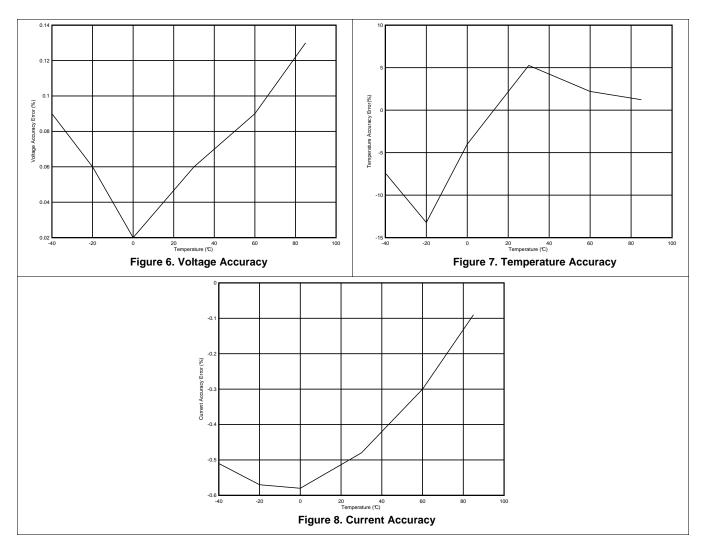
bq27421-G1 SLUSB85C-MAY 2013-REVISED DECEMBER 2014



www.ti.com

# **Typical Applications (continued)**

# 10.2.3 Application Curves





# 11 Power Supply Recommendation

# 11.1 Power Supply Decoupling

The battery connection on the BAT pin is used for two purposes:

- To supply power to the fuel gauge
- As an input for voltage measurement of the battery

A capacitor of value of at least 1  $\mu$ F should be connected between BAT and V<sub>SS</sub>. The capacitor should be placed close to the gauge IC and have short traces to both the BAT pin and V<sub>SS</sub>.

The fuel gauge has an integrated LDO with an output on the V<sub>DD</sub> pin of approximately 1.8 V. A capacitor of value at least 0.47  $\mu F$  should be connected between the V<sub>DD</sub> pin and V<sub>SS</sub>. The capacitor should be placed close to the gauge IC and have short traces to both the V<sub>DD</sub> pin and V<sub>SS</sub>.



# 12 Layout

## 12.1 Layout Guidelines

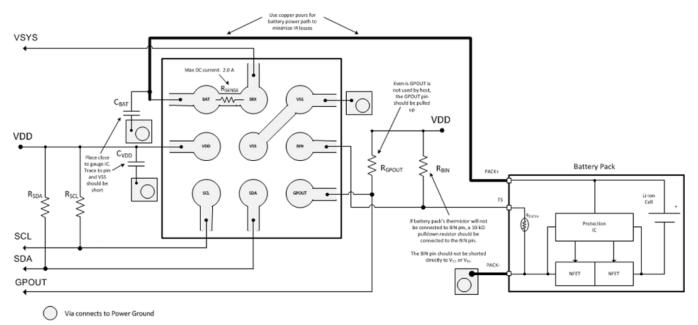
- A capacitor, of value at least 0.47  $\mu$ F, is connected between the V<sub>DD</sub> pin and V<sub>SS</sub>. The capacitor should be placed close to the gauge IC and have short traces to both the V<sub>DD</sub> pin and V<sub>SS</sub>.
- It is required to have a capacitor, at least 1.0 μF, connected between the BAT pin and V<sub>SS</sub> if the connection between the battery pack and the gauge BAT pin has the potential to pick up noise. The capacitor should be placed close to the gauge IC and have short traces to both the V<sub>DD</sub> pin and V<sub>SS</sub>.
- If the external pullup resistors on the SCL and SDA lines will be disconnected from the host during low-power operation, it is recommend to use external 1-MΩ pulldown resistors to V<sub>SS</sub> to avoid floating inputs to the I<sup>2</sup>C engine.
- The value of the SCL and SDA pullup resistors should take into consideration the pullup voltage and the bus capacitance. Some recommended values, assuming a bus capacitance of 10 pF, can be seen in Table 4.

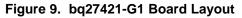
 Table 4. Recommended Values for SCL and SDA Pullup Resistors

VPU	1.8 V		3.3 V				
Р	Range	Typical	Range	Typical			
R <sub>PU</sub>	$400 \ \Omega \leq R_{PU} \leq 37.6 \ k\Omega$	10 kΩ	900 $\Omega \leq R_{PU} \leq 29.2 \ k\Omega$	5.1 kΩ			

- If the GPOUT pin is not used by the host, the pin should still be pulled up to  $V_{DD}$  with a 4.7-k $\Omega$  or 10-k $\Omega$  resistor.
- If the battery pack thermistor is not connected to the BIN pin, the BIN pin should be pulled down to V<sub>SS</sub> with a 10-kΩ resistor.
- The BIN pin should not be shorted directly to V<sub>DD</sub> or V<sub>SS</sub>.
- The actual device ground is the center pin (B2). The C1 pin is floating internally and can be used as a bridge to connect the board ground plane to the device ground (B2).

# 12.2 Layout Example







# **13** Device and Documentation Support

# **13.1 Documentation Support**

### 13.1.1 Related Documentation

- bq27421-G1 Technical Reference Manual (SLUUAC5)
- bq27421 EVM: Single-Cell Technology User's Guide (SLUUA63)
- Quickstart Guide for bq27421-G1 (SLUUAH7)
- Single Cell Gas Gauge Circuit Design (SLUA456)
- Key Design Considerations for the bq27500 and bq27501 (SLUA439)
- Single Cell Impedance Track Printed-Circuit Board Layout Guide (SLUA457)
- ESD and RF Mitigation in Handheld Battery Electronics (SLUA460)

## 13.2 Trademarks

Impedance Track, NanoFree are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

### 13.3 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# 13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



# PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
BQ27421YZFR-G1A	ACTIVE	DSBGA	YZF	9	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ27421 G1A	Samples
BQ27421YZFR-G1B	ACTIVE	DSBGA	YZF	9	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ27421 G1B	Samples
BQ27421YZFR-G1D	ACTIVE	DSBGA	YZF	9	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ27421 G1D	Samples
BQ27421YZFT-G1A	ACTIVE	DSBGA	YZF	9	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ27421 G1A	Samples
BQ27421YZFT-G1B	ACTIVE	DSBGA	YZF	9	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ27421 G1B	Samples
BQ27421YZFT-G1D	ACTIVE	DSBGA	YZF	9	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ27421 G1D	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



# PACKAGE OPTION ADDENDUM

14-Nov-2014

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# PACKAGE MATERIALS INFORMATION

www.ti.com

Texas Instruments

# TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ27421YZFR-G1A	DSBGA	YZF	9	3000	180.0	8.4	1.78	1.78	0.69	4.0	8.0	Q1
BQ27421YZFR-G1B	DSBGA	YZF	9	3000	180.0	8.4	1.78	1.78	0.69	4.0	8.0	Q1
BQ27421YZFR-G1D	DSBGA	YZF	9	3000	180.0	8.4	1.78	1.78	0.69	4.0	8.0	Q1
BQ27421YZFT-G1A	DSBGA	YZF	9	250	180.0	8.4	1.78	1.78	0.69	4.0	8.0	Q1
BQ27421YZFT-G1B	DSBGA	YZF	9	250	180.0	8.4	1.78	1.78	0.69	4.0	8.0	Q1

TEXAS INSTRUMENTS

www.ti.com

# PACKAGE MATERIALS INFORMATION

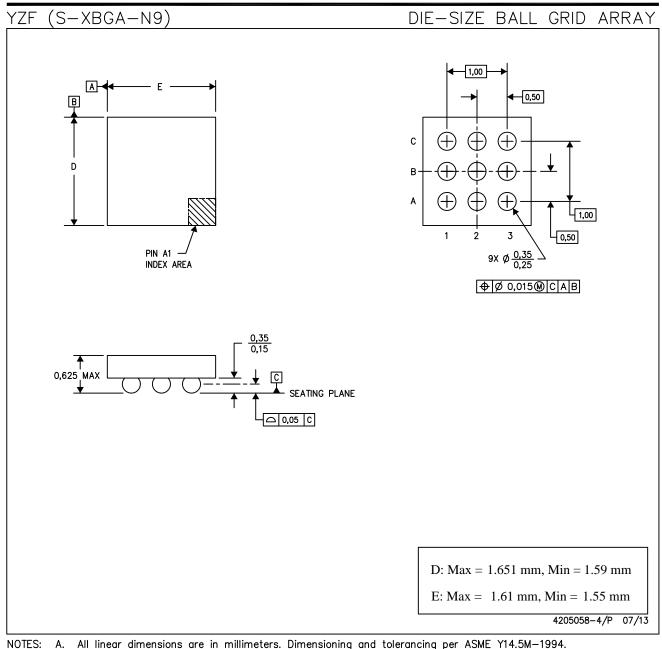
14-Nov-2014



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ27421YZFR-G1A	DSBGA	YZF	9	3000	182.0	182.0	17.0
BQ27421YZFR-G1B	DSBGA	YZF	9	3000	182.0	182.0	17.0
BQ27421YZFR-G1D	DSBGA	YZF	9	3000	182.0	182.0	17.0
BQ27421YZFT-G1A	DSBGA	YZF	9	250	182.0	182.0	17.0
BQ27421YZFT-G1B	DSBGA	YZF	9	250	182.0	182.0	17.0

# **MECHANICAL DATA**





- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.

NanoFree is a trademark of Texas Instruments.



#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Applications Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconne	ctivity	

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2015, Texas Instruments Incorporated



# Authorized Distribution Brand :



# Website :

Welcome to visit www.ameya360.com

# Contact Us :

➤ Address :

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd Minhang District, Shanghai , China

- > Sales :
  - Direct +86 (21) 6401-6692
  - Email amall@ameya360.com
  - QQ 800077892
  - Skype ameyasales1 ameyasales2

# > Customer Service :

Email service@ameya360.com

# > Partnership :

Tel +86 (21) 64016692-8333

Email mkt@ameya360.com